Application/Control No. Applicant(s)/Patent Under Reexamination 10/614,291 SHIRAKATA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2662 David Odland **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY US-6,662,367 12-2003 Dapper et al. 370/478 Α US-5,710,990 01-1998 Long et al. 455/103 В US-6,304,545 10-2001 C Armbruster et al. 370/210 US-D US-Ε US-F US-G USн US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N ò Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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